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SPECIFICATIONS

X1G004211003600 **Product No.:**

TG-5006CG-57H **MODEL:**

A15-1031-0B SPEC. No.:

Nov. 18. 2015 **DATE:**

SEIKO EPSON CORPORATION

8548 Naka-minowa Minowa-machi Kamiina-gun Nagano-ken 399-4696 Japan

CHECKED Kunihito Yamanaka / TD Products Development Department Manager

CHECKED <u>A. Za Avmale</u> -/ TD Products Development Department Senior Staff
Atsushi Kakumae

Yasushi Hiraizumi / TD · CS Quality Assurance Department Manager

PREPARED ____

/ TD • CS Quality Assurance Department Senior Staff

SPECIFICATIONS

1. Application

This document is applicable to the temperature compensated crystal oscillator (TCXO) that is delivered to . from SEIKO EPSON Corp.

This product is compliant with RoHS Directive.

This TG-5006CG-57H is authorized for Use of Car navigation system for automobile only.

This Product supplied (and any technical information furnished, if any) by SEIKO EPSON Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes.

Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use.

We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

2. Product No. / Model

The product No. of this crystal oscillator unit is X1G004211003600.

The model is TG-5006CG-57H (TCXO)

Packing

It is subject to the packing standard of SEIKO EPSON Corp.

4. Amendment and abolishment

Amendment and/or abolishment of this specification are subject to the agreement of both parties.

5. Contents

Item No.	Item	Page
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[1] Characteristics

- Lead Free Reflowable and ultra small SMD($2.5 \times 2.0 \times 0.8$ mm Typ.).
- Using the heat-resisting type AT cut quartz crystal allows almost the same temperature soldering as universal SMD IC.

• Operating supply voltage : 1.8 V, 2.8 V, or 3.0 V

[2] Absolute maximum ratings

Parameter	Symbol	Value	Unit	Note
Supply voltage	V _{CC} -GND	-0.3 to 4.0	V	
Storage temperature range	T_stg	-40 to +90	°C	

[3] Operating range

	Devenuetes			Value		Unit	Note
	Parameter	Symbol	Min.	Тур.	Max.	Unit	Note
Supply	Supply voltage		1.7		3.3	V	
Supply			0.0		0.0	٧	
Operation	Operating temperature range		-30	+25	+85	°C	
Output I	Output load		9	10	11	kΩ	
		Load_C	9	10	11	pF	
	DC-cut capacitor	C _C	0.01			μF	

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DC-cut capacitor is not included in this TCXO.

Please insert DC-cut capacitor in output line.

[4] Frequency characteristics

1) Output frequency 26.000000 MHz

2) Frequency characteristics

(Condition: $V_{CC} = 1.8V$, 2.8V, 3.0V or 3.3V, GND = 0.0V, Load $10k\Omega//10pF(DC cut)$, $T_use = +25^{\circ}C$)

(Condition :)	<u>CC 1.01, 2.0</u>	Load Total Topi (Bo odly, T_doo 120 0)					
Parameter	Symbol		Value	!	Unit	Note	
Farameter	Symbol	Min.		Max.	Offic	Note	
Crassian est talarana	f_tol(osc)	-1.0	-	+1.0	×10 ⁻⁶	T_use = +25°C ±2°C Before reflow soldering	
Frequency tolerance	f_tol *1	-2.0	-	+2.0	×10 ⁻⁶	T_use = +25°C ±2°C Reflow cycle : 2 times *2	
Frequency / Temperature characteristics	fo-Tc	-0.5	-	+0.5	×10 ⁻⁶	T_use = -30°C to +85°C Based on frequency at +25°C	
Frequency / Load coefficient	fo-Load	-0.2	-	+0.2	×10 ⁻⁶	Load :10kΩ // 10pF ±5 %each	
Frequency / Voltage coefficient	fo-V _{CC}	-0.2	-	+0.2	×10 ⁻⁶	V _{CC} ±5% *3	
Frequency aging	f_age	-1.0	-	+1.0	×10 ⁻⁶	First year T_use =+25°C	

^{*1} Include initial frequency tolerance and frequency deviation after reflow cycles.

[5] Electrical characteristics

(Condition : V_{CC} = 1.8V, 2.8V, 3.0V or 3.3V, GND = 0.0V, Load $10k\Omega//10pF(DC cut)$, $T_use = +25^{\circ}C$)

Parameter	Symbol	Value			Unit	Note	
Farameter	Symbol	Min.	Тур.	Max.	Offic	Note	
Current consumption	I _{cc}	-	-	1.5	mA		
Output level	V_{PP}	0.8	-	1.5	٧	Peak to peak voltage Clipped sine wave	
Symmetry	SYM	40	-	60	%	GND Level	
Harmonics	-	-	-	-8	dBc	All harmonics	
Start up time	t otr	-	-	2.0		Until output signal has been reached min 90% of final amp.	
Start up time	t_str	-	-	2.0	msec	Until frequency has been reached within $\pm 1 \times 10^{-6}$ of final frequency.	
		-	-	-83		Offset:10 Hz	
		-	-	-108	3	Offset:100 Hz	
SSB Phase noise	l (f)	-	-	-135	dBc	Offset:1 kHz	
33b Fliase Hoise	L(f)	-	-	-148	/Hz	Offset:10 kHz	
		-	-	-148		Offset:100 kHz	
		-	-	-150		Offset:1 MHz	

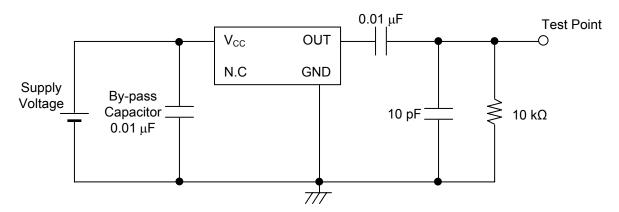
3

^{*2} Measurement of frequency deviation is made 24h after reflow soldering.

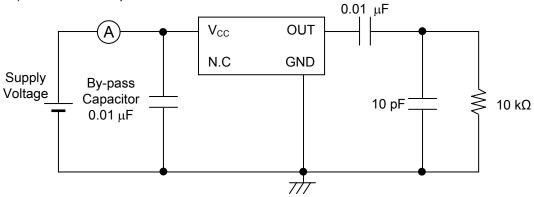
^{*3} V_{CC} ±5% must be in operating supply voltage range. (1.7 V to 3.3 V)

[6] Test circuit

1) Output Load : $10 k\Omega//10 pF$



2) Current consumption



3) Conditions

Impossible to measure both frequency and wave form at the same time.(In case of using oscilloscope's amplifier output, possible to measure both at the same time.)

- 2. Load_C includes probe capacitance.
- 3. A capacitor (By-pass:0.01 $\,\mu F$) is placed between V_{CC} and GND,and closely to TCXO.

4

- 4. Use the current meter whose internal impedance value is small.
- 5. Power Supply

Impedance of power supply should be as low as possible.

6. GND pin should be connected to low impedance GND.

[7] Environmental and mechanical characteristics

(The company evaluation condition. we evaluate it by the following examination item and examination condition.)

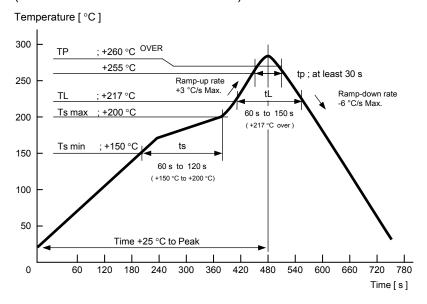
		Value *1				
No.	Item	Freq. Tolerance [1×10 ⁻⁶] *2	Test method			
		Electrical characteristics				
1	High temp. storage *3	±2.0	+85 °C × 1000 h			
2	Low temp. storage *3	±2.0	-40 °C × 1000 h			
3	High temp. with humidity	±2.0	+85 °C × 85%RH × 1000 h			
4	Temp. cycle *3	±2.0	-40 °C to +85 °C (30 min × 100 cycle/each)			
	Resistance to					
5	Soldering heat	±1.0	Reflow furnace with the condition 3 times			
	(Reflow characteristics)					
			150g dummy jig (SEIKO EPSON Standard)			
6	Drop	±2.0	drop from 1500 mm height on the concrete 6			
			directions 3 times.			
			10 Hz to 55 Hz amplitude 0.75 mm			
7	Vibration	+2.0	55 Hz to 500 Hz acceleration 98 m/s ²			
'	VIDIALIOII	ΞΖ.U	10 Hz \rightarrow 500 Hz \rightarrow 10 Hz 15 min / cycle			
			6 h (2 h × 3 directions)			
8	Solderability	Terminals must be 95 %	Dip termination into solder bath at +235 °C for			
0	Soluerability	covered with fresh solder	5 s (Using Rosin Flux)			

Notes

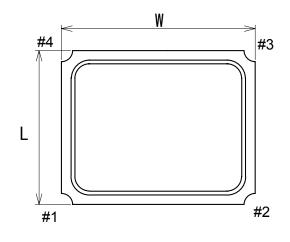
- 1.*1 each test is independent.
- 2.*2 measuring 2 h to 24 h later leaving in room temperature after each test.
- 3.*3 Initial value shall be measured after 24 h storage at room temperature Pre-treatment

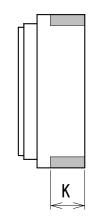
Pre-treatment : Bake (+125°C x 24 h) \rightarrow Moisture soak (+85°C x 85 % x 168 h) \rightarrow reflow (3 times)

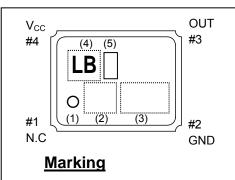
Reflow condition (follow to IPC / JEDEC J-STD-020D.1)



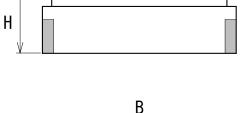
[8] Dimensions and marking layout

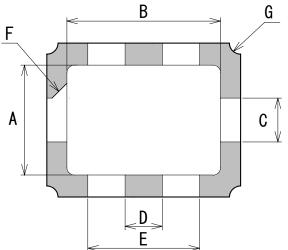


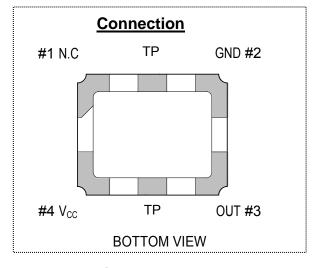




- (1) 1Pin Mark
- (2) Arbitrary marking area(2digits)(3) TCXO LOT NO.
- (3) TCXO LOT NO. (3digits)
- (4) TCXO Model ID (LB)
- (5) Image recognition mark







Material

Base : Ceramics

Terminal: Au plated nickel

(unit: mm)

Dim.	Min.	Тур.	Max.	Dim.	Min.	Тур.	Max.
W	2.30	2.50	2.70	D	0.40	0.50	0.60
L	1.80	2.00	2.20	Е	1.35	1.50	1.65
Н	0.70	0.80	0.90	F		C0.2	
Α	1.35	1.50	1.65	G		R0.15	
В	1.95	2.10	2.25	K		0.45	
С	0.50	0.60	0.70				

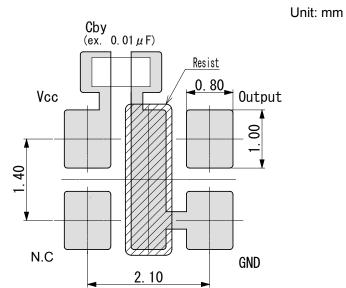
[9] Recommendable patterning

For actual design work, please consider optimum condition together with mounting density, reliability of soldering and mount ability etc.

Please connect Cby(bypass capacitor) quite near by "Vcc" terminal.

Do not design any patterns except GND on the shaded area.

Soldering position



[10] Handling precautions

Prior to using this product, please carefully read the section entitled "Precautions" on our Web site (http://www5.epsondevice.com/en/quartz/tech/precaution/) for instructions on how to handle and use the product properly to ensure optimal performance of the product in your equipment. Before using the product under any conditions other than those specified therein, please consult with us to verify and confirm that the performance of the product will not be negatively affected by use under such conditions.

In addition to the foregoing precautions, in order to avoid the deteriorating performance of the product, we strongly recommend that you <u>DO NOT</u> use the product under <u>ANY</u> of the following conditions:

- (1) Mounting the product on a board using water-soluble solder flux and using the product without removing the residue of the flux completely from the board. The residue of such flux that is soluble in water or water-soluble cleaning agent, especially the residues which contains active halogens, will negatively affect the performance and reliability of the product.
- (2) Using the product in any manner that will result in any shock or impact to the product.
- (3) Using the product in places where the product is exposed to water, chemicals, organic solvent, sunlight, dust, corrosive gasses, or other materials.
- (4) Using the product in places where the product is exposed to static electricity or electromagnetic waves.
- (5) Applying ultrasonic cleaning without advance verification and confirmation that the product will not be affected by such a cleaning process, because it may damage the crystal, IC and/or metal line of the product.
- (6) Touching the IC surface with tweezers or other hard materials directly.
- (7) Using the product under any other conditions that may negatively affect the performance and/or reliability of the product.
- (8) Using the product with power line ripple exceeding 50 mV(p-p) level.

Should any customer use the product in any manner contrary to the precautions and/or advice herein, such use shall be done at the customer's own risk.

TAPING SPECIFICATION

テープ梱包基準書

1. APPLICATION 適用範囲

This document is applicable to 2.5 x 2.0 SMD package. 本基準書は、2.5 x 2.0 セラミックパッケージのテーピング梱包について規定する。

2. CONTENTS 目次

Item No.	Item	Page
[1]	Taping specification テーピング仕様	1 to 2
[2]	Inner Sleeve スリーブへの収納	3
[3]	Shipping carton 外装箱への収納	
[4]	Marking 表示	4
[5]	Quantity 収納数量	
[6]	Storage environment 保管環境	
[7]	Handling リール取扱い	

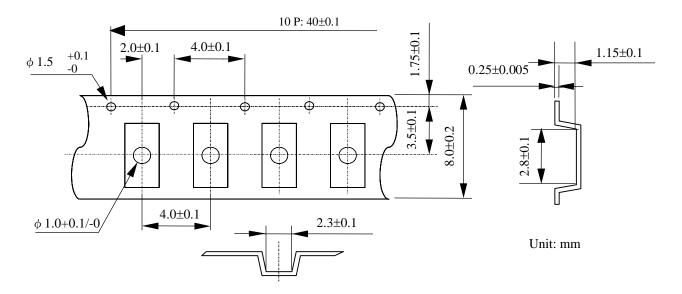
[1] Taping specification テーピング仕様

Subject to EIA-481 , IEC 60286.

「EIA-481」「IEC 60286」に準拠する。

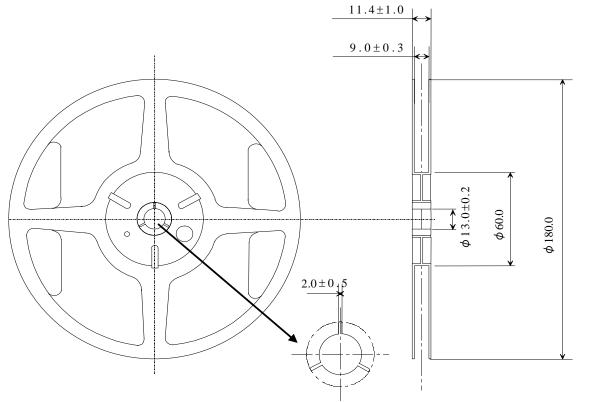
(1) Tape dimensions TE0804L

Material of the Carrier Tape キャリアテープ材質: PS (Black / Conductive 黒/導電性) Material of the Top Tape トップテープ材質 : PET+PE



(2) Reel dimensions

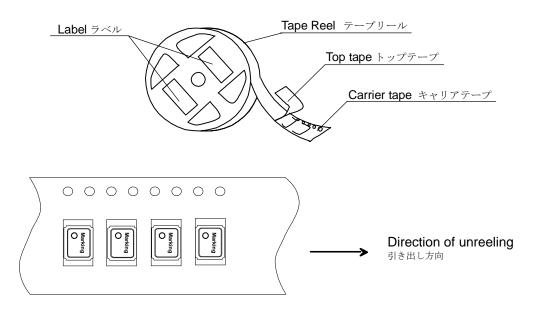
Material of the Reel リール材質: PS (Black / Conductive 黒/導電性)



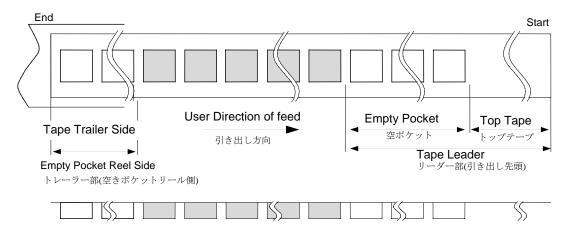
Form and Size of reel window shows are one of the example リールの窓の形状は代表例を掲載。

(3) Packing 収納形態

(a) Tape & Reel デバイス収納方法



(b) Start & End Point 引き出し先頭側及びリール側の処理



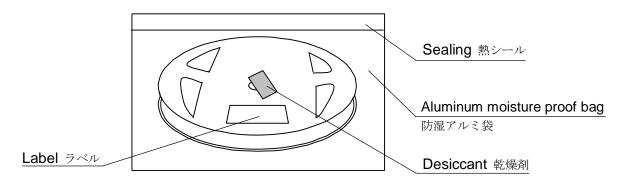
	em ^{頁目}	Empty Space 空きスペース	Note 備考		
Tape Leader (引き出し先頭側)	Top Tape	Min. 200 mm	Feeding in the Top tape, the tip is fixed with tape. トップテーブ単独で繰り出し、先端はテーブにより固定。		
	Carrier Tape	Min. 150 mm	Winding method is a diagram of the above リールへの巻き取り方法は、上図の通り。		
Tape Trailer	Top Tape	Min. 0 mm			
(リール側)	Carrier Tape	Min. 150 mm	Tip is fixed to the reel. 先端はリールに固定。		

(4) Peel force of the cover tape トップテープの剥離強度

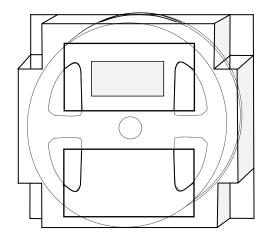
- (a) Angle: cover tape during peel off and the direction of unreeling shall be 165° to 180°. 剥離角度:テープの接着面に対し165~180 度とする。
- (b) Peel speed: 300 mm/min. 剥離速度:300 mm/min とする。
- (c) Peel strength: 0.1 ~ 1.0 N. 剥離強度:0.1~1.0 N

[2] Inner sleeve

a) Packing to antistatic bag 袋への収納



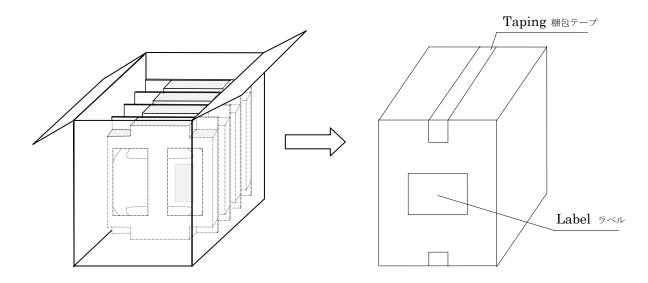
b) Packing to inner sleeve スリーブへの収納



- *There is also a case to put the two reel.
- * 2リール収納される場合もあります。

[3] Shipping Carton 外装箱への収納

- Put inner sleeve into an outer box.
 外装箱の中へ、スリーブを収納する。
- If there is space in the outer box, material is put in a shock absorbing together. 空間ができた時は、クッション材を入れる。



[4] Marking 表示

- (1) Reel marking リールへの表示
 - Reel marking shall consist of

下記内容をリール表面に表示できるラベルを貼る。:

- 1) Parts name 製品名称
- 2) Quantity 製品数量
- 3) Manufacturing Date or symbol 製品の製造年月又はこれを示す記号
- 4) Manufacturer's Date or symbol 製品の製造業者又はその略号
- 5) Others (if necessary) その他必要事項
- (2) Shipping carton marking 外装箱への表示
 - Shipping carton marking shall consist of: 下記内容を外装箱表面に表示できるラベルを貼る。:
 - 1) Parts name 製品名称
 - 2) Quantity 製品数量

[5] Quantity 収納数量

- Maximum 2 000 pcs./reel 最大 2,000 個/リール
- Minimum 500 pcs./reel 最小 500 個/リール

[6] Storage environment 保管環境

(1) To use it less than 6 month after delivery.

貴社納入後、6ヶ月以内の実装を推奨します。

(2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 4 weeks. No need dry air before soldering work if it is less than temperature +30 °C, 65 humidity %RH.

使用直前まで開梱せず、袋開封後は 4 週間以内の実装を推奨します。 温度 +30 $^{\circ}$ C、湿度 65 %RH以下では、はんだ付け作業前に乾燥不要です。

(3) Not to storage with some erosive chemicals.

化学薬品類との同居を避ける。

(4) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

内・外装箱がゆがまないようまた、外圧がかからないように保管して下さい。

[7] Handling リール取扱い

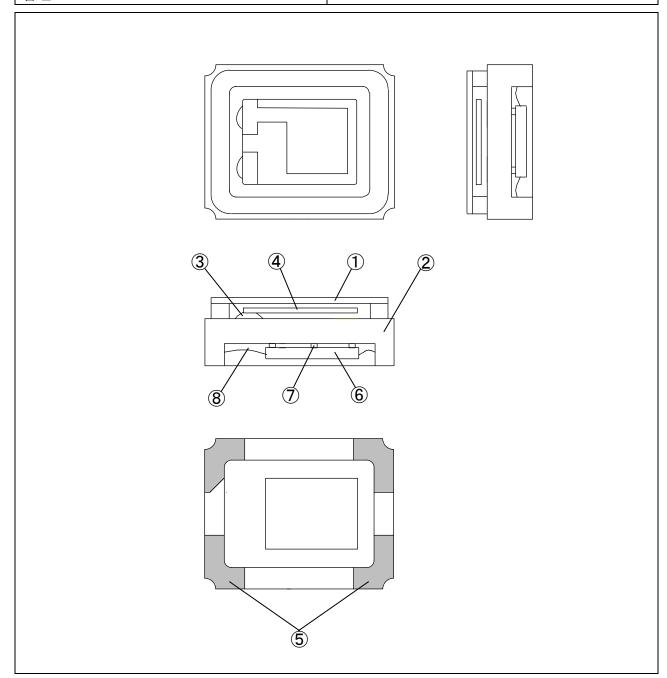
To handle with care to prevent the damage of tape, reel and products.

リールの取扱いについては、中のテープ・製品を変形させないようにして下さい。

CRYSTAL OSCILLATOR: TG-50xxCx series

	uring process chart	No.	Section In Charge	Standards	Inspection, Control Item	Instruments	Inspection Methods	Record
Au Wire	IC Wafer 1 ··· In-coming	1	Inspection Section	Purchase specification Delivery card	Appearance	Visual inspection	Every lot	Data sheet
	Inspection	2	Production Section	Specification (Work standard)	Heater temperature Bump dimension Shear strength	Thermometer Microscope Bond tester	Daily Sampling Sampling	Daily check sheet Data sheet Data sheet
	Bump Bonding	3	Production Section	Specification (Work standard)	Cutting condition Appearance	Visual inspection	Daily	Daily check sheet
	3 Tape mounting	4	Production Section	Specification (Work standard)	Abrasion loss of Blade	Built-in gauge	Every batch	Tool change check sheet
	4 Dicing	5	Production Section	Specification (Work standard)	Water resistance	Built-in meter	Daily	Daily check sheet
Crystal Unit	5 Wafer Cleaning	6	Production Section	Specification (Work standard)	Dicing condition	Microscope	Sampling	Data sheet
	6 Appearance Inspection	7	Production Section	Specification (Work standard)	UV condition	UV intensity meter	Daily	Daily check sheet
	7 UV irradiation	8	Production Section	Specification (Work standard)	Flow rate of O2 and Ar	Built-in meter	Daily	Daily check sheet
8 Plasma etching	9 Flip chip bonding	9	Production Section	Specification (Work standard)	Number of US tool shots Number of ejector needle shot. Heater temperature Bump dimension Shear strength	Built-in counter Built-in counter Thermometer Microscope Bond tester	100% 100% Daily Sampling Sampling	Tool change check sheet Daily check sheet Data sheet Data sheet
		10	Production Section	Specification (Work standard)	Flipchip bonding Condition	Microscope	Sampling	Data sheet
	Appearance inspection	11	Production Section	Specification (Work standard)	Chip coat storage temp. Pot lifetime	Thermometer Built-in timer	Daily 100%	Daily check sheet Tool change check sheet
	Under fill filling	12	Production Section	Specification (Work standard)	Curing time Oven temperature	Timer Thermometer	Every batch Daily	Data sheet Daily check sheet
	12 Curing	13	Production Section	Specification (Work standard)	Appearance (FC & Under fill condition)	Microscope	100% Inspection	Data sheet
	13 Appearance inspection	14	Production Section	Specification (Work standard)	Reflow profile	Thermometer	Daily	Daily check sheet
	(14) Reflow	15	Production Section	Specification (Work standard)	Stage temperature	Thermometer	Daily	Daily check sheet
	T4 Kenow	16	Production Section	Specification (Work standard)	Stage temperature	Thermometer	Daily	Daily check sheet
	1st Temp. characteristic test	17	Production Section	Specification (Work standard)	Stage temperature Temperature characteristic	Thermometer Measuring equipment	Daily 100% Inspection	Daily check sheet Data sheet
Consistent equipment	ROM writing	18	Production Section	Specification (Work standard)	Electrical characteristics Master confirmation	Measuring equipment	100% Inspection	Data sheet
	Temperature characteristic inspection	19	Production Section	Specification (Work standard)	Appearance Marking	CCD camera	100% Inspection	Data sheet
	Electrical characteristic	20	Production Section	Specification (Work standard)	Peeling off strength Direction	Peel back tester Visual inspection	Daily Sampling Delivery lot	Daily check sheet Data sheet
Consistent equipment	inspection Marking	21	Inspection Section	Specification (Work standard)	Electrical characteristics Appearance	Measuring equipment Visual inspection	Sampling	Data sheet
	Taping	22	Production Control Section	Specification (Work standard)	Quantity	Visual inspection	Sampling Delivery lot	Data sheet Delivery record
	Out going inspection							
	22 Packaging & Shipping							

Structure Diagram 構造	図	Rev.02
Model 型式	TG-50xxCE / TG-50xxCG / TG-50xxCJ	
Document No. 管理№.	TG-50xxCx_D_0001	



No.	Name of Part 部品名	No.	Name of Part 部品名
1	Lid リッド	5	Terminal 端子
2	Package パッケージ	6	IC IC
3	Crystal adhesive 接着材	7	FC bump FC バンプ
4	Crystal chip 水晶片	8	Underfill アンダーフィル



RELIABILITY TEST DATA

Product Name: TG-50xxCG series

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition.

DTA-1510 E

we evaluate chymolinental and meenameal characteristics by the following test condition:							
			VALUE *1		TEST	FAIL	
No.	ITEM	TEST CONDITIONS	$\Delta f/f *2$	Electrical	Qty	Qty	
			$[1 \times 10^{-6}]$	characteristics	[n]	[n]	
1	High temperature	+85 °C × 1 000 h	*3 ± 2.0 *3 ± 2.0		22	0	
1	storage	+83 C × 1 000 n			22	U	
2	Low temperature	-40 °C × 1 000 h			22	0	
	storage	-40 C × 1 000 II				U	
3	High Temperature	$+85 \pm 2$ °C × 85 ± 5 %RH × 1 000 h	*3		22	0	
	with Humidity		± 2.0				
4	Temperature cycle	-40 °C ⇔ +85 °C	*3 ± 2.0	Satisfy output level after test	22	0	
		30 min at each temp. 1000 cycles					
5	Resistance to soldering heat	Convection reflow soldering furnace	± 1.0		22		
		(3 times)			22	0	
		150 1 ". (CEHZO EDGON C		-	-		
6	Drop	150g dummy jig (SEIKO EPSON Standard)	± 2.0		22	0	
		drop from 1500 mm height on the concrete 6 directions 3 times.			22	0	
		10 Hz to 55 Hz amplitude 0.75 mm					
7	Vibration	55 Hz to 500 Hz acceleration 98 m/s ²					
			± 2.0		22	0	
		$10 \text{ Hz} \rightarrow 500 \text{ Hz} \rightarrow 10 \text{ Hz}$ 15 min/cycle					
		6 h (2 h × 3 directions) Dip termination into solder bath at	Termination must be				
8	Solderability	-			11	0	
		$+235$ °C ± 5 °C for 5 s	covered with fresh solder more than 95 % of dip area.		11	U	
		(Using Rosin Flux)					

Notes

- 1. *1 Each test done independently.
- 2. *2 Measuring 2 h to 24 h later leaving in room temperature after each test.
- 3. *3 Initial value shall be measured after 24 h storage at room temperature Pre-treatment Pre-treatment: Bake (+125 $^{\circ}$ C × 24 h) \rightarrow Moisture soak (+85 $^{\circ}$ C × 60 % × 168 h) \rightarrow reflow (3 times)

Product Name: TG-50xxCG series

